

# Search Notes



Application/Control No.

10/519,322

Examiner

Sam K. Ahn

Applicant(s)/Patent under  
Reexamination

CHEN ET AL.

Art Unit

2611

## SEARCHED

Class	Subclass	Date	Examiner
375	216, 280 324, 329	8/11	an
7144	786		
375	262, 279 316, 329, 331		
375	333		
370	207	8/11	an

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST, 1000 & gauge inventor, keyword & citation search	8/11	an